IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant:

Kazuhiro NAKAJIMA et al.

Appl. No.:

NEW NON-PROVISIONAL

Group:

Filed:

July 24, 2003

Examiner:

For:

PRODUCTION PROCESS FOR PRODUCING

SEMICONDUCTOR DEVICES, SEMICONDUCTOR

DEVICES PRODUCED THEREBY, AND TEST SYSTEM

FOR CARRYING OUT YIELD-RATE TEST IN

PRODUCTION OF SUCH SEMICONDUCTOR DEVICES

INFORMATION DISCLOSURE STATEMENT (SUBMISSION CONCURRENT WITH THE FILING OF A NEW PATENT APPLICATION)

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

July 24, 2003

Sir:

Pursuant to 37 C.F.R. §§ 1.97 and 1.98, and in fulfillment of the duty of disclosure under 37 C.F.R. § 1.56, applicant(s) hereby submit(s) an Information Disclosure Statement for consideration by the Examiner.

I. LIST OF PATENTS, PUBLICATIONS OR OTHER INFORMATION

The patents, publications, or other information submitted for consideration by the Office are listed on PTO-1449, attached hereto.

II. COPIES

- Submitted herewith is a legible copy of (i) each U.S. and foreign patent; (ii) each publication or that portion which caused it to be listed; and (iii) all other information or that portion which caused it to be listed.
- This application is a National Phase of a PCT application. Some or all of the documents listed on the PTO-1449 are not enclosed because they were cited in the International Search Report and copies should have been forwarded from the International Search Authority pursuant to the trilateral agreement between the USPTO, EPO and JPO. If copies are needed, please contact the undersigned.

III. CONCISE EXPLANATION OF THE RELEVANCE (check at least one box)

a. DOCUMENTS IN THE ENGLISH LANGUAGE

The attached patents, publications, or other information in the English language do not require a

statement of relevancy.

b. M DOCUMENTS NOT IN THE ENGLISH I	٥.	IXI	DOCUMENTS	NOT	IN	THE	ENGLISH	LANGUAGE
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A concise explanation of the relevance of all patents, publications, or other information listed that is not in the English language is as follows:

Abstract provided for the examiner's convenience

c. FOREIGN SEARCH REPORT OR ACTION

An English language version of the search report or action that indicates the degree of relevance found by the foreign office is attached, thereby satisfying the requirement for a concise explanation. See MPEP 609(A)(3).

The following additional information is provided for the Examiner's consideration.

FEES

This Information Disclosure Statement is being filed concurrently with the filing of a new patent application; therefore, no fee is required.

If The Examiner has any questions concerning this IDS, he/she is requested to contact the undersigned.

Respectfully submitted,

YOUNG & THOMPSON

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BC/yr

Enclosures:

Form PTO-1449(s)

□ Documents

Foreign Search Report

Other:_____

F10-1449													
INFORMATION DISCLOSURE CITATION					Attorney Docket No.: 8053-1016	Application No.: NEW NONPROVISIONAL							
IN AN APPLICATION					Applicant: Kazuhiro NAKAJIMA et al.								
(Use several sheets if necessary)					Filing Date: July 24, 2003	Group Art Unit:							
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

^{*} Abstract provided for the Examiner's convenience